

Likelihood Based Uncertainty Bounding in Prediction Error Identification using ARX models

A Simulation Study

ECC 2007, Kos, Greece

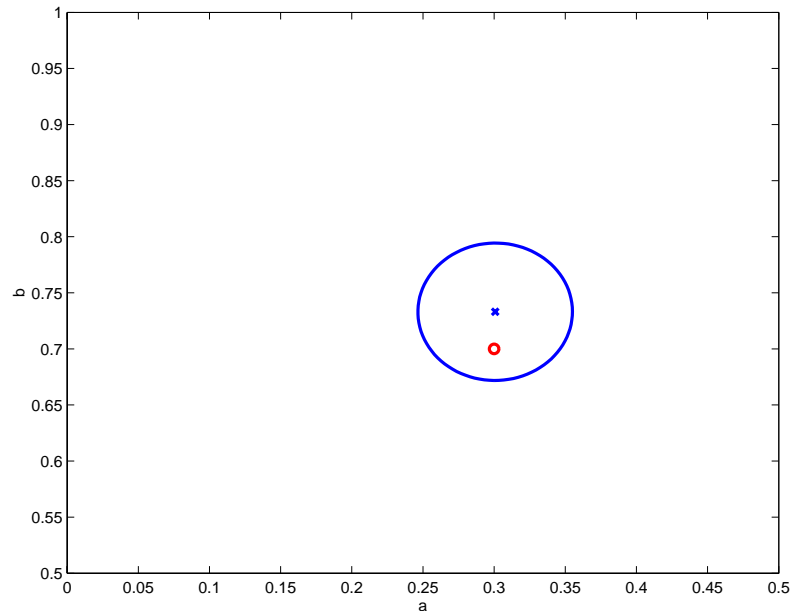
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1

Confidence regions

A 95% confidence region is a region in parameter space that attempts to cover the "true" parameter with probability 0.95.

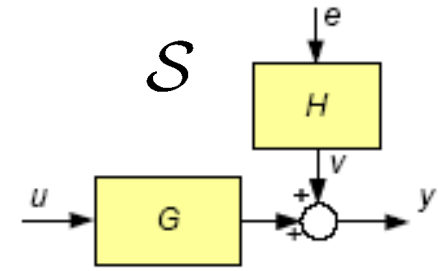


Outline

- Data generating system and predictor model
- Statistical inference in PE identification
- Confidence regions and hypothesis tests
- Test statistics
- ARX modelling
- Simulation results
- Conclusions

Data generating system and predictor model

$$y(t) = G_0(q)u(t) + H_0(q)e(t)$$



- input (deterministic): $u^N = \{u(t)\}_{t=1,\dots,N}$
- output (stochastic): $y^N = \{y(t)\}_{t=1,\dots,N}$
- $e(t)$ Gaussian white noise

Predictor model set ($S \in \mathcal{M}$):

$$\mathcal{M} := \{(G(q, \theta), H(q, \theta)) \mid \theta \in \Theta \subset \mathbb{R}^n\}$$

$$\exists \theta_0 \quad \ni \quad G(q, \theta_0) = G_0(q) \text{ and } H(q, \theta_0) = H_0(q)$$

Statistical inference

One-step ahead predictor:

$$\hat{y}(t|t-1; \theta) = H^{-1}(q, \theta)G(q, \theta)u(t) + [1 - H^{-1}(q, \theta)]y(t)$$

Prediction errors:

$$\epsilon(t, \theta) = y(t) - \hat{y}(t|t-1; \theta)$$

$$\epsilon(t, \theta_0) = e(t) \sim \mathcal{N}(0, \sigma^2)$$

Joint probability density function of y^N :

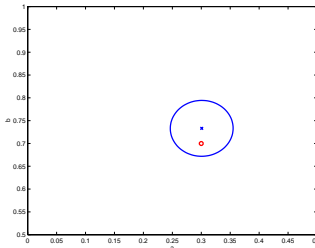
$$f_y(y^N; \theta_0) = \prod_{t=1}^N \frac{1}{\sqrt{2\pi\sigma^2}} \exp \left[-\frac{1}{2\sigma^2} \underbrace{(y(t) - \hat{y}(t|t-1; \theta_0))^2}_{\epsilon(t, \theta_0)} \right]$$

Statistical inference

$$S(\theta) = \frac{\partial \log f_y(y^N; \theta)}{\partial \theta} = \frac{-N \partial V_N(\theta)}{2\sigma^2 \partial \theta}$$

$$F(\theta) = -\mathbb{E} \left[\frac{\partial^2 \log f_y(y^N; \theta)}{\partial \theta^2} \right] = \frac{N}{2\sigma^2} \mathbb{E} \left[\frac{\partial^2 V_N(\theta)}{\partial \theta^2} \right]$$

$$\hat{\theta}_N = \arg \max_{\theta} f_y(\theta; y^N) = \arg \min_{\theta} \underbrace{\frac{1}{N} \sum_{t=1}^N \epsilon(t, \theta)^2}_{V_N(\theta)}$$



Confidence region for θ_0 ?

Construction of confidence regions

$$H_0 : \theta_0 = \theta$$

$$H_1 : \theta_0 \neq \theta$$

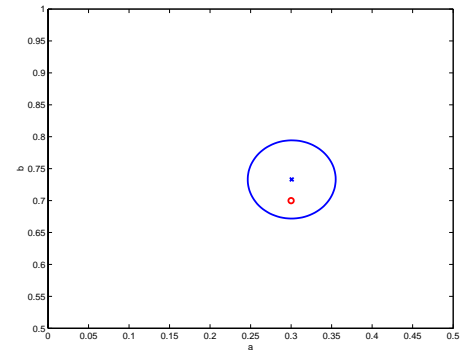
To test H_0 against H_1 at significance level α , choose a test statistic $T(y^N, \theta)$ with a known distribution under H_0 and decide H_1 if:

$$T(y^N, \theta) > c(\alpha)$$

with $Pr[T(y^N, \theta) > c(\alpha)] = \alpha$ under H_0 .

100(1 - α)% confidence region for θ_0 :

$$\{\theta | T(y^N, \theta) \leq c(\alpha)\}$$



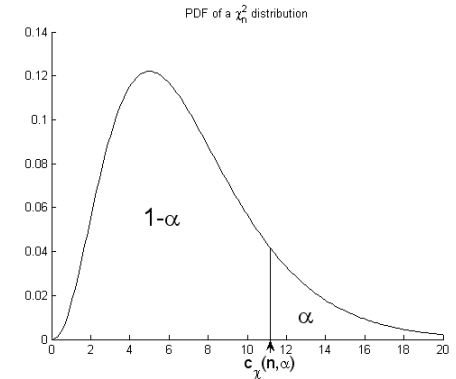
Test statistics

$\hat{\theta}_N \stackrel{as.}{\sim} \mathcal{N}(\theta_0, F^{-1}(\theta_0))$	$(\hat{\theta}_N - \theta_0)^T F(\theta_0)(\hat{\theta}_N - \theta_0) \stackrel{as.}{\sim} \chi_n^2$
$S(\theta_0) \stackrel{as.}{\sim} \mathcal{N}(0, F(\theta_0))$	$S(\theta_0)^T F^{-1}(\theta_0)S(\theta_0) \stackrel{as.}{\sim} \chi_n^2$
$-2 \log \frac{f_y(\theta_0; y^N)}{f_y(\hat{\theta}_N; y^N)} = \frac{N}{\sigma^2} (V_N(\theta_0) - V_N(\hat{\theta}_N)) \stackrel{as.}{\sim} \chi_n^2:$	

$$\left. \begin{aligned} T_T(y^N, \theta) &= (\hat{\theta}_N - \theta)^T F(\theta)(\hat{\theta}_N - \theta) \\ T_W(y^N, \theta) &= (\hat{\theta}_N - \theta)^T F(\hat{\theta}_N)(\hat{\theta}_N - \theta) \\ T_R(y^N, \theta) &= S(\theta)^T F^{-1}(\theta)S(\theta) \\ T_{LR}(y^N, \theta) &= \frac{N}{\sigma^2} (V_N(\theta) - V_N(\hat{\theta}_N)) \end{aligned} \right\} \stackrel{as.}{\sim} \chi_n^2 \text{ under } H_0$$

(100 - α)% confidence regions for θ_0 :

$$\left\{ \theta \mid T(y^N, \theta) \leq c_\chi(n, \alpha) \right\}$$



ARX modelling

$$G(q, \theta) = \frac{q^{-n_k}(b_0 + b_1q^{-1} + \dots + b_{n_b-1}q^{-n_b+1})}{1 + a_1q^{-1} + \dots + a_{n_a}q^{-n_a}}$$

$$H(q, \theta) = \frac{1}{1 + a_1q^{-1} + \dots + a_{n_a}q^{-n_a}}$$

$$\theta^T = [a_1 \dots a_{n_a} b_0 \dots b_{n_b-1}]$$

$$\varphi^T(t) = [-y(t-1) \dots -y(t-n_a)u(t-n_k) \dots u(t-n_k-n_b+1)]$$

$$\Phi = \begin{pmatrix} \varphi^T(1) \\ \vdots \\ \varphi^T(N) \end{pmatrix}$$

$$\mathbf{y}^T = [y(1) \dots y(N)]$$

$$N(V_N(\theta) - V_N(\hat{\theta}_N)) = (\theta - \hat{\theta}_N)^T \Phi \Phi^T (\theta - \hat{\theta}_N)$$

$$S(\theta) = \frac{1}{\sigma^2} \Phi^T (\mathbf{y} - \Phi \theta); \quad F(\theta_0) = \frac{1}{\sigma^2} \underbrace{\mathbb{E} [\Phi^T \Phi]}_{R(\theta_0)}$$

Confidence regions for ARX parameters

100(1 - α)% confidence regions for θ_0 :
 $\left\{ \theta \mid (\theta - \hat{\theta}_N)^T X (\theta - \hat{\theta}_N) \leq \sigma^2 c_\chi(n, \alpha) \right\}$

Test statistic	X
T_T	$R(\theta)$
T_W (Wald)	$R(\hat{\theta}_N)$
T_R (Rao)	$\Phi^T \Phi R^{-1}(\theta) \Phi^T \Phi$
T_{LR} (Likelihood Ratio)	$\Phi^T \Phi$

$$R(\theta_0) = \mathbb{E} \left[\Phi^T \Phi \right].$$

Result from asymptotic theory (θ_0 known)

Asymptotically valid expression for $\text{cov}(\hat{\theta}_N)$:

$$P_{\theta_0} = \frac{\sigma^2}{N} \left(\lim_{N \rightarrow \infty} \frac{1}{N} \sum_{t=1}^N \mathbb{E}_{ue} [\varphi(t) \varphi^T(t)] \right)^{-1}$$

100(1 - α)% confidence region for θ_0

$$\left\{ \theta \mid (\hat{\theta}_N - \theta)^T P_{\theta_0}^{-1} (\hat{\theta}_N - \theta) \leq c_{\chi}(n, \alpha) \right\}$$

Simulation experiment

50.000 data sets (y^N, u^N)

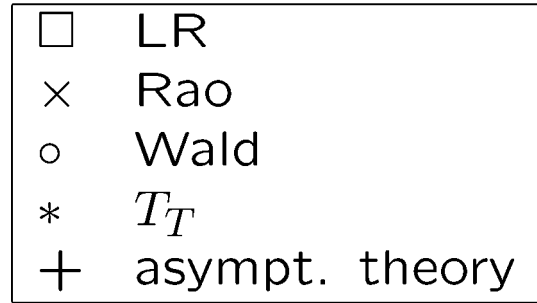
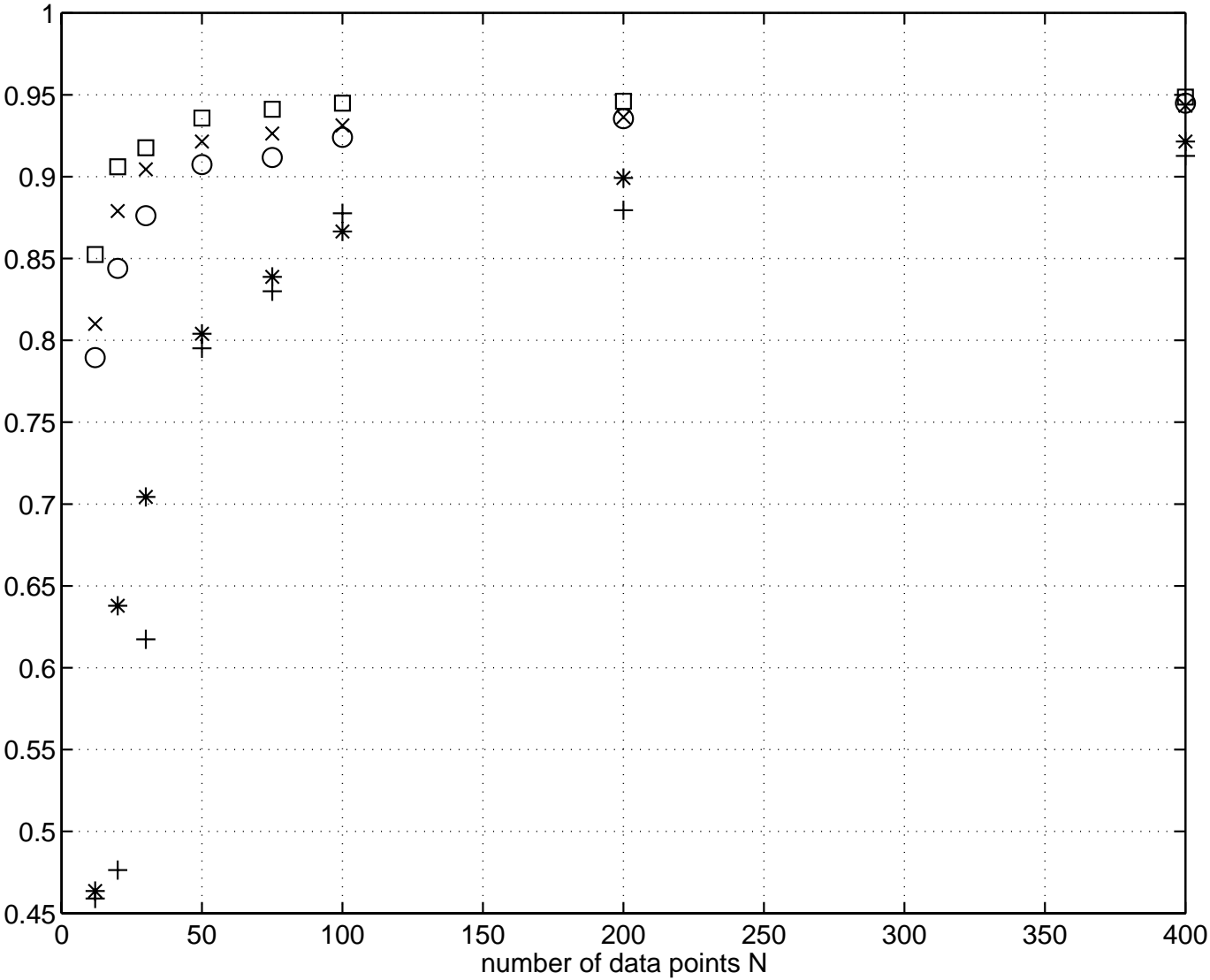
Data generating system \mathcal{S} :

$$y(t) - 1.5578y(t-1) + 0.5769y(t-2) = \\ 0.1047u(t-1) + 0.0872u(t-2) + e(t)$$

u^N (known) and e^N (unknown) realizations of Gaussian white noise proces, $\sigma_u^2 = 1, \sigma_e^2 = 0.5$.

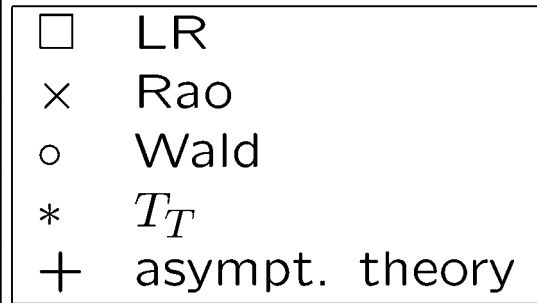
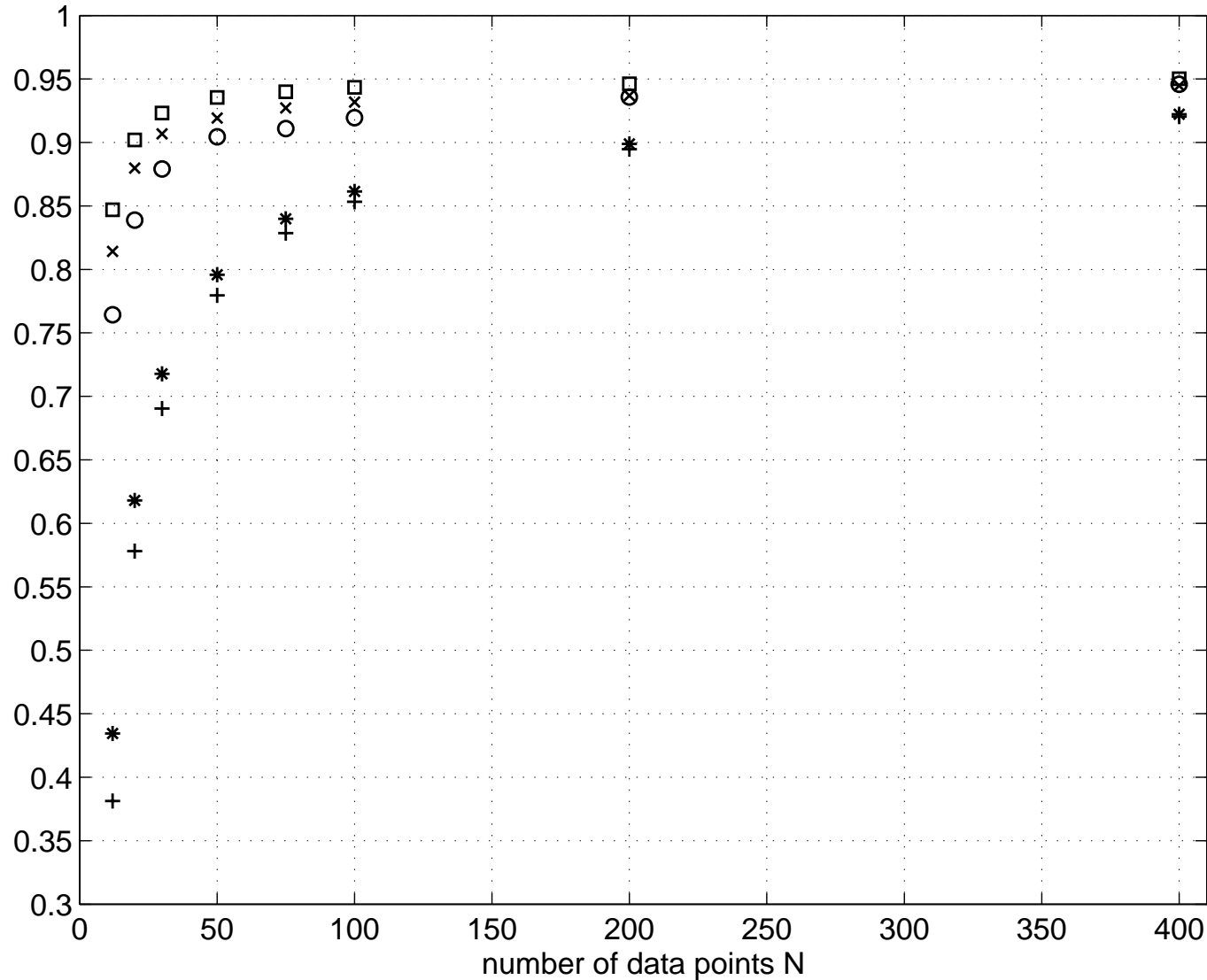
For each data set, the model was identified and it was recorded if the constructed confidence regions contained θ_0 .

observed coverage rates



$K=50.000$
 e^N varied
 u^N fixed
 $\alpha = 0.05$

observed coverage rates



$K=50.000$
 e^N varied
 u^N varied
 $\alpha = 0.05$

Conclusions

100(1 - α)% confidence regions for ARX:

$$\left\{ \theta \mid (\theta - \hat{\theta}_N)^T X (\theta - \hat{\theta}_N) \leq \sigma^2 c_X(n, \alpha) \right\}$$

- Confidence regions that incorporate information on the particular noise realization e^N in X (via Φ or $\hat{\theta}_N$) are most reliable.
- Confidence region based on LR test statistic ($X = \Phi^T \Phi$) performs best (in simulations).

ARX modelling

$$\varphi(t, \theta_0) = s_u(t, \theta_0) + s_e(t, \theta_0),$$

$$s_u(t, \theta_0) = \frac{\Lambda_G(q^{-1}, \theta_0)}{H(q^{-1}, \theta_0)} u(t); \quad s_e(t, \theta_0) = \frac{\Lambda_H(q^{-1}, \theta_0)}{H(q^{-1}, \theta_0)} e(t),$$

with $\Lambda_G(q^{-1}, \theta)$ and $\Lambda_H(q^{-1}, \theta)$ the $n \times 1$ gradient vectors of the transfer function $G(q^{-1}, \theta)$ and $H(q^{-1}, \theta)$ with respect to θ , respectively.

$$R(\theta_0) = \sum_{t=1}^N s_u(t, \theta_0) s_u^T(t, \theta_0) + \sum_{t=1}^N \mathbb{E} \left[s_e(t, \theta_0) s_e^T(t, \theta_0) \right]$$

Result from asymptotic theory (θ_0 known)

Asymptotically valid expression for $\text{cov}(\hat{\theta}_N)$:

$$P_{\theta_0} = \frac{\sigma^2}{2\pi N} \left(\int_{-\pi}^{\pi} \left(\Gamma_G(e^{i\omega}, \theta_0) \Phi_u(\omega) + \Gamma_H(e^{i\omega}, \theta_0) \sigma^2 \right) d\omega \right)^{-1}$$

$$\Gamma_G(e^{i\omega}, \theta_0) = \frac{\Lambda_G(e^{i\omega}, \theta_0) \Lambda_G^*(e^{i\omega}, \theta_0)}{H(e^{i\omega}, \theta_0) H^*(e^{i\omega}, \theta_0)},$$

$$\Gamma_H(e^{i\omega}, \theta_0) = \frac{\Lambda_H(e^{i\omega}, \theta_0) \Lambda_H^*(e^{i\omega}, \theta_0)}{H(e^{i\omega}, \theta_0) H^*(e^{i\omega}, \theta_0)}$$

with $\Phi_u(\omega)$ the power spectrum of $u(t)$.

$$\theta_0 \in \left\{ \theta \mid (\hat{\theta}_N - \theta)^T P_{\theta_0}^{-1} (\hat{\theta}_N - \theta) \leq c_{\chi}(n, \alpha) \right\} \quad \text{w.p. } 1 - \alpha$$